Call for Papers ADMETA^{Plus} 2017



Advanced Metallization Conference 2017: 27th Asian Session

Oct. 18–20, 2017

The University of Tokyo, Yayoi Auditorium, Ichijo Hall (Hongo Campus), Tokyo **Sponsorship by ADMETA Committee**

Co-sponsorship by the Japan Society of Applied Physics

The ADMETA^{Plus} is heading for its 27th historical meeting and has a long record of important contributions to practical progress for advanced MPU and various memory devices. In recent years, the importance of interconnect technology for realizing low resistance, large integration, rich functionality, low cost, and high reliability has increased in various device application fields beyond silicon electronics. This conference will focus on interconnect technology and science related to materials, processes, device design, assembly, equipment, cost performance, and characterization. We will host comprehensive discussions on a wide range of topics, from basics to applications, with researchers and engineers from industry, government, and academia. We are looking forward to new developments in interconnect technology fields and contributing to the growth of the semiconductor industry in the Asian area.

ADMETA Plus 2017 General Chair: Osamu Nakatsuka (Nagoya University)

Conference Topics of Interest

Integration: Interconnection Structure and Performance, Parasitic Capacitance, Reliability Technology, Testing and Analysis

Reliability Science and Failure Analysis: EM, SIV, TDDB, Defect Detection and Analysis, Failure Mechanism and Modeling

Metallization: PVD, CVD, ALD, Plating, Barrier Metal, Seed and Nucleation Layer, Supercritical Fluid, Reflow

Low-k Dielectric: CVD, ALD, SOD, Film Properties, Interface Control, New Materials, Dielectric Structures (Air Gap), Metrology, etc.

CMP: Planarization Technology, Slurry, Pad, Dress, End Point Detection, Cleaning, Anti-corrosive Technology, etc.

Contact: Silicide, Interface, Solid Phase Reaction, Shallow Junction, Crystal Properties, Electron Properties, Carrier Transport, Parasitic Resistance, etc.

MEMS/RF: Interconnection Structure and Materials, Packaging, Fabrication Process Technology, Device Design, etc.

Emerging Technology: Active Wiring, Power Electronics, Silicon Photonics, Flexible Electronics, Energy Harvesting, etc.

Backend Device Technology: Technology for Embedding Devices (MRAM, PCRAM, ReRAM, DRAM, etc.), Materials and Processing of Magnetics, Phase-Change and Resistive-Change Devices, Electrodes, Metallization, etc.

Nanocarbon: Graphene, Carbon Nanotube, Deposition, Integration, Electrical Characteristics, Reliability, Evaluation, Analysis, etc.

3D and Packaging: TSV, TMV, Stacking Method (CoW, WoW), Thinning, Planarization, Bonding, Bump, Stress and Thermal Analysis, Sealing, Cooling, Reliability

★ To Apply: Prepare an abstract per the directions below and submit it to the ADMETA Plus 2017

A4 format, 2 pages, Oral [15 min. talk & 5 min. QA] or Poster [90 min.] (temporary) ★ Abstract Preparation and Submission: Abstracts are due: June 30, 2017 >> July 13, 2017

Prospective authors must submit a two-page PDF file with all figures and tables. Send the PDF file of the manuscript, the subject of your paper (please choose from the Conference Topics of Interest), and desired presentation style (Oral or Poster) to the secretariat office via e-mail. On the abstract, please indicate the author to whom correspondence should be addressed, and include mailing and e-mail addresses. A template for your abstract can be downloaded from the ADMETA^{Plus} 2017 website. Notification of acceptance will be made to the authors by August 14, 2017. Upon notification, authors will be requested to confirm their participation in the conference.

The accepted abstracts will be included in the conference proceedings (paper and/or CD-ROM), which the participants will receive on site at the registration desk of ADMETA Plus 2017. Pre-registered participants will also be able to download the accepted abstracts from the ADMETA Plus 2017 webpage after Oct. 16, 2016.

Authors with papers presented at ADMETA Plus 2017 are encouraged to submit their original manuscripts to a Special Issue of the Japanese Journal of Applied Physics (JJAP) dedicated to the ADMETA Plus 2017. The deadline for submission to the Special Issue is November 20, 2017. The manuscripts will be reviewed based on the JJAP standard for an original paper. The JJAP Special Issue will accept regular papers (RP), brief notes (BN), and reviews (RV) and will be published in July, 2018.

Reminder: As the papers of the Special Issue will be original papers, please be careful not to post the same contents to any other journals.

★ Contact: ADMETA^{Plus} 2017 Secretariat

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